
CODES FOR CHAPTER 12

mmmie.f, mmmiea.f

Fortran77 programs `mmmie` and `mmmiea` calculate Mie coefficients (scattering coefficients a_n and b_n , efficiencies Q_{sca} , Q_{ext} and Q_{abs} , see Section 12.2 for definitions), and relate them to particle cloud properties (extinction coefficient β , absorption coefficient κ , scattering coefficient σ_s , scattering phase function Φ for specified scattering angles. In addition, program `mmmiea` also calculates the asymmetry factor g , and phase function expansion coefficients A_n , as defined in Section 12.3), but at a severe penalty in cpu time.

The input for both programs is the same, and is done via a data file `MIE.DAT`:

Input:

IDSTF	= 1: single particle size; =2: modified gamma distribution
IETA	= 1: single wavenumber; =2: wave number spectrum
IPRNT	= 1: print only final results; =2: also intermediate integrations
CIR	= complex index of refraction
RMIN	= minimum particle size in gamma distribution (in μm)
RMAX	= maximum particle size in gamma distribution (in μm)
AMG,	= constants in gamma distribution, equation (12.34), $\text{FR}(\text{R}) = \text{AMG} * \text{R}^{**} \text{ALMG} * \text{DEXP}(-\text{BMG} * \text{R}^{**} \text{GAMG})$; units: AMG [$\text{cm}^{-3} \mu\text{m}^{\text{ALMG}+1}$], ALMG [-], BMG [μm^{-1}], GAMG[-]
ALMG,	
GAMG	
NPV	= number of particles per unit volume (in particles/ cm^3)
ETA	= wavenumber if single wavenumber is considered (in cm^{-1})
ETMIN	= minimum wavenumber to be considered
ETMAX	= maximum wavenumber to be considered
NETA	= number of wavenumbers to be considered (equally spaced between ETMIN and ETMAX)
ERRP	= maximum error allowed for absorption/scattering coefficients (and also the asymmetry factor for <code>mmmiea</code>)(in %)
ERRA	= maximum absolute error desired for phase function values (<code>mmmie</code>) or expansion coefficients A_n (<code>mmmiea</code>) (in $10^{-\text{digits}}$)

Note: to allow running the program on machines with relatively little RAM, array sizes have been declared fairly small, limiting calculations to (i) a maximum of 10 different wavenumbers, (ii) relatively small size parameters ($x \lesssim 300$), and (iii) relatively coarse integration intervals (< 500 nodes). More involved problems can be calculated by carefully increasing array limits as indicated in the programs.

Example:

The input file `MIE.DAT` as given in this directory, contains the following data:

```
2, 1, 2
(1.30149, -0.1620E-05)
1.-10 1.+10,
1.619424-4, 0.740741, 7.6, 1., 74.
10000.
1. .005
```

stating that a gamma-distribution of particles is to be considered for a single wavenumber, with detailed output (including intermediate integrations) (first line).

The complex index of refraction of the particles is $m = 1.30149 - 0.1620 \times 10^{-5}i$ (second line).

Particle sizes range from $10^{-10} \mu\text{m}$ to $10^{+10} \mu\text{m}$ (third line).

Gamma-function parameters in equation (12.34) are $A = 1.61942410^{-4}$, $B = 0.740741$, $\gamma = 7.6$, $\delta = 1$. The number of particles is given as $N(T) = 74/\text{cm}^3$ (this number is really not necessary for a gamma distribution, since it can be calculated from equation (12.35), and is only read and printed, but not used) (fourth line). Since only a single wavenumber is considered, the fifth line contains only one number, $\eta = 100000 \text{ cm}^{-1}$. Finally, the last line specifies to calculate κ , σ and β to an accuracy of 1% or better, and that the values for Φ or A_n should be calculated to an absolute accuracy of 0.005.

Running `mmme` produces the following self-explanatory output, placed into file MIE.RES:

```
PARAMETERS FOR PARTICLE DISTRIBUTION/SINGLE WAVENUMBER
```

```
*****
```

```
WAVENUMBER      = 0.100E+05 CM-1
MINIMUM PARTICLE RADIUS= 0.100E-09 MICROM
MAXIMUM PARTICLE RADIUS= 0.100E+11 MICROM
REFRACTIVE INDEX      = 1.3015-0.0000i
PARTICLE DENSITY      = 0.740E+02 PER CM**3
DISTRIBUTION FUNCTION: N(R)=0.16194E-03*R**7.6*EXP(-0.74074E+00*R**1.0)
```

```
MIE-PARAMETERS ARE CALCULATED FOR 16.00000 < X < 216.00000
```

```
INTEGRATION WITH 9 NODES, AND A DX =25.000
```

ETA (CM-1)	1.000E+04
KAPPA (CM-1)	1.250E-07
SIGMA (CM-1)	3.675E-04
BETA (CM-1)	3.676E-04

PHASE FUNCTION

DEG.	PHI
0	4.835E+03
1	1.943E+03
2	2.093E+02
3	5.329E+01
.	
.	
.	
176	2.264E-01
177	1.503E-01
178	2.086E-01
179	3.508E-01
180	1.364E+00

```
INTEGRATION WITH 17 NODES, AND A DX =12.500
```

ETA (CM-1)	1.000E+04
KAPPA (CM-1)	9.997E-08
SIGMA (CM-1)	3.667E-04
BETA (CM-1)	3.668E-04

PHASE FUNCTION

DEG.	PHI
0	4.634E+03

1	1.851E+03
2	2.304E+02
3	4.943E+01

.	.
.	.
177	2.428E-01
178	3.551E-01
179	3.691E-01
180	9.224E-01

INTEGRATION WITH 65 NODES, AND A DX = 3.125

ETA (CM-1)	1.000E+04
KAPPA (CM-1)	1.023E-07
SIGMA (CM-1)	3.684E-04
BETA (CM-1)	3.685E-04

PHASE FUNCTION

DEG.	PHI
0	4.617E+03
1	1.847E+03
2	2.331E+02
3	6.044E+01

INTEGRATION DID NOT CONVERGE: MAXIMUM ERROR = 0.18%

ERROR FOR SIGMA : 0.18%, ERROR FOR BETA : 0.18%

ERROR FOR

PHASE(1):	2.84309
PHASE(2):	2.45336
PHASE(3):	1.56688
PHASE(4):	0.47940
PHASE(5):	0.23725

PHASE(179):	0.03003
PHASE(180):	0.05414
PHASE(181):	0.10000

ETA (CM-1)	1.000E+04
KAPPA (CM-1)	9.785E-08
SIGMA (CM-1)	3.677E-04
BETA (CM-1)	3.678E-04

PHASE FUNCTION

DEG.	PHI
0	4.614E+03
1	1.845E+03
2	2.347E+02
3	6.092E+01
4	3.153E+01

```

5      2.034E+01
6      1.511E+01
7      1.234E+01
8      1.066E+01
9      9.560E+00
.
.
.
170     7.660E-02
171     1.032E-01
172     1.213E-01
173     1.069E-01
174     9.150E-02
175     1.214E-01
176     1.629E-01
177     2.179E-01
178     2.986E-01
179     2.761E-01
180     7.212E-01

```

Running **mmmmiea**, on the other hand produces the following output, placed into file **MIEA.RES**:

```

PARAMETERS FOR PARTICLE DISTRIBUTION/SINGLE WAVENUMBER
*****
WAVENUMBER          = 0.100E+05 CM-1
MINIMUM PARTICLE RADIUS= 0.100E-09 MICROM
MAXIMUM PARTICLE RADIUS= 0.100E+11 MICROM
REFRACTIVE INDEX    = 1.30149-1.62000E-06i
PARTICLE DENSITY     = 7.400E+01 PER CM**3
DISTRIBUTION FUNCTION: N(R)=1.61942E-04*R**7.6*EXP(-0.74074E+00*R**1.0)

```

MIE-PARAMETERS ARE CALCULATED FOR 16.00000 < X < 216.00000

INTEGRATION WITH 9 NODES, AND A DX =25.000

```

ETA (CM-1)      1.000E+04
KAPPA (CM-1)    1.250E-07
SIGMA (CM-1)    3.675E-04
BETA (CM-1)     3.676E-04
GCOS (--)       8.691E-01
A( 1)           2.60744
A( 2)           4.02359
A( 3)           4.85462
A( 4)           5.53582
A( 5)           6.29942
A( 6)           6.88010
A( 7)           7.63828
A( 8)           8.43823
A( 9)           9.15186
.
.
.
A(449)          0.00000
A(450)          0.00000
A(451)          0.00000
A(452)          0.00000

```

INTEGRATION WITH 33 NODES, AND A DX = 6.250

ETA (CM-1)	1.000E+04
KAPPA (CM-1)	1.015E-07
SIGMA (CM-1)	3.681E-04
BETA (CM-1)	3.682E-04
GCOS (--)	8.716E-01
A(1)	2.52586
A(2)	3.88357
A(3)	4.68158
A(4)	5.32619
A(5)	6.04063
A(6)	6.59512
A(7)	7.31633
A(8)	8.08751
A(9)	8.72379
A(10)	9.58797
.	
.	
A(449)	0.00000
A(450)	0.00000
A(451)	0.00000
A(452)	0.00000

PHASEFUNCTION

DEG.	PHI
0	4.260E+03
5	1.758E+01
10	8.615E+00
15	5.157E+00
20	4.088E+00
25	3.059E+00
30	2.206E+00
35	1.287E+00
40	1.089E+00
45	6.978E-01
50	7.122E-01
55	3.592E-01
60	2.251E-01
65	1.581E-01
70	1.343E-01
75	9.730E-02
80	8.906E-02
85	6.900E-02
90	5.605E-02
95	4.968E-02
100	5.518E-02
105	5.099E-02
110	4.992E-02
115	5.291E-02
120	5.204E-02
125	8.062E-02
130	5.287E-02
135	2.674E-01
140	2.485E-01

145	1.552E-01
150	1.190E-01
155	1.194E-01
160	1.216E-01
165	1.328E-01
170	1.030E-01
175	1.690E-01
180	9.319E-01

coalash.f90, coalash.exe

This Fortran90 program determines absorption and extinction coefficients κ^* , β^* for the Rayleigh limit, from the Buckius and Hwang [1] model, as well as from the Mengüç and Viskanta [2] model. The user is prompted to input the complex index of refraction n and k as well as the nondimensional size parameter x of the coal/ash particles; results are then printed to the screen.

References

1. Buckius, R. O., and D. C. Hwang: "Radiation properties for polydispersions: Application to coal," *ASME Journal of Heat Transfer*, vol. 102, pp. 99–103, 1980.
2. Mengüç, M. P., and R. Viskanta: "On the radiative properties of polydispersions: A simplified approach," *Combustion Science and Technology*, vol. 44, pp. 143–159, 1985.